

Notice of References Cited	Application/Control No. 10/584,729		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Caridad M. Everhart		Art Unit 2891	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0213770	11-2003	Yamada et al.	216/65
*	B	US-2002/0070352	06-2002	ALLAN et al.	250/492.1
*	C	US-2006/0144828	07-2006	Fukumitsu et al.	219/121.67
*	D	US-2004/0087118	05-2004	Maegawa et al.	438/514
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.